

Specification for

Harmonized system of quality assessment for electronic components — Blank detail specification —

Fixed chip capacitors with metallized
electrodes and
polyethylene-terephthalate film
dielectric for direct current

Amendments issued since publication

Amd. No.	Date	Comments

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National foreword

This British Standard has been prepared under the direction of the Electronic Components Standards Committee. It is identical with CENELEC Electronic Components Committee (CECC) 32201:1987 “*Blank detail specification: Fixed chip capacitors with metallized electrodes and polyethylene-terephthalate film dielectric for direct current*”.

This standard is a harmonized specification within the CECC System.

Terminology and conventions. The text of the CECC specification has been approved as suitable for publication as a British Standard without deviation. Some terminology and certain conventions are not identical with those used in British Standards; attention is drawn especially to the following.

The comma has been used as a decimal marker. In British Standards it is current practice to use a full point on the baseline as the decimal marker.

Cross-references. The British Standard which implements CECC 00100 is BS 9000: “*General requirements for a system for electronic components of assessed quality*” — Part 2:1983 “*Specification for national implementation of CECC basic rules and rules of procedure*”.

International Standard	Corresponding British Standard
^a IEC 286-3:1986	BS 6062-3 <i>Packaging of electronic components for automatic handling</i> ^b Part 3: <i>Packaging of leadless components on continuous tapes</i> (Identical)
IEC 410:1973	BS 6001 <i>Sampling procedures for inspection by attributes</i> . Part 1:1972 <i>Specification for sampling plans indexed by acceptable quality level (AQL) for lot-by-lot inspection</i> . (Technically equivalent)
CECC 30000:1983	BS CECC 30000:1984 <i>Harmonized system of quality assessment for electronic components: Generic specification: Fixed capacitors</i> . (Identical)
CECC 32200:1987	^b BS CECC 32200: <i>Harmonized system of quality assessment for electronic components: Sectional specification: Fixed chip capacitors with metallized electrodes and polyethylene-terephthalate dielectric for direct current</i> . (Identical)

^a IEC = International Electrotechnical Commission.

^b In preparation.

Scope. This standard lists the ratings, characteristics and inspection requirements that shall be included as mandatory requirements in accordance with BS CECC 32200 in any detail specification for these devices.

Detail specification layout. The front page layout of detail specifications released to BS CECC family or blank detail specifications will be in accordance with PD 9004 Circular Letter No. 15.

A British Standard does not purport to include all the necessary provisions of a contract. Users of British Standards are responsible for their correct application.

Compliance with a British Standard does not of itself confer immunity from legal obligations.

Summary of pages

This document comprises a front cover, an inside front cover, pages i to iv, the CECC title page, pages ii to iv, pages 1 to 8 and a back cover.

This standard has been updated (see copyright date) and may have had amendments incorporated. This will be indicated in the amendment table on the inside front cover.

